

PTO/SB/08A (08-03)

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Substitut	e for form 1448A/PTC	o .		Complete If Known				
				Application Number	10/809,635			
	INFORMATION DISCLOSURE		Filing Date	March 24, 2004				
STA	STATEMENT BY APPLICANT			First Named Inventor	Jun Feng			
	•			Group Art Unit	1848 [624			
	(use as many sheets as necessary)		Examiner Name	Not Yet Assigned K. Maboc				
Sheet	1	of	10	Attorney Docket Number	SYR-DPP-IV-5004-U			

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Substitu	Substitute for form 1449A/PTO			Complete if Known		
				Application Number	10/809,635	
INFO	DRMATIO	n dis	CLOSURE	Filing Date	March 24, 2004	
STA	STATEMENT BY APPLICANT			First Named Inventor	Jun FENG	
				Group Art Unit	1624	
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Examiner Signature	Mon	1/h	Date Considered	8/1/	2006

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				Group Art Unit	1624		
	(use as many sh	100ls as	necessary)	Examiner Name	Kahsay Habte		
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Sheet of 2

Complete if Known						
Application Number	10/809,635					
Filing Date	March 24, 2004					
First Named Inventor	Jun FENG					
Group Art Unit	- 1648- 1624					
Examiner Name	K. HABTC					
Attorney Dockel Number	SYR-DPP-IV-5004-U					

	U.S. PATENT DOCUMENTS									
c	Examiner		Document Number	Publication Date/	Name of Patentee or Applicant of	Process Codemon Library Million Outcomed				
	ats.	No."	Number - Kind Code ³ (# known)	Issue Date	Cited Document	Peges, Columns, Lines, Where Relevant Pessages or Retevant Figures Appear				
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	(AB	US2002/0169159	11-14-2002	Medina et al.					
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Examiner Initials*	Cite No.	Country Code ³ - Number ⁶ - Kind Code ⁶ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		T [©]
KN	AD	BR 899812	11-29-1950	The Distillers Company Limited		
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$\perp V$	AO	WO 04/085408 A1	10-07-2004	Mitsubishi Pharma		

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